SPECIFICATIONS

AO Medium TeO2 4.2 mm/µs Acoustic Velocity Active Aperture* 1 mm 'L' X 0.1 mm 'H' Center Frequency (Fc) 200 MHz RF Bandwidth 90 MHz @ -10 dB Return Loss Input Impedance 50 Ohms Nominal VSWR @ Fc 1.3:1 Max Wavelength 1047-1060 nm

Insertion Loss 4 % Max

Reflectivity per Surface 0.5 % Max

Anti-Reflection Coating MIL-C-48497

Optical Power Density 50 MW/cm²

Contrast Ratio 1000 :1 Min

Polarization 90 ° To Mounting Plane

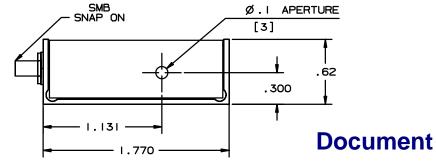
PERFORMANCE VS WAVELENGTH

Wavelength (nm)	1060
Saturation RF Power (W)	2.5
Bragg Angle (mr)	25.2
Beam Separation (mr)	50.4

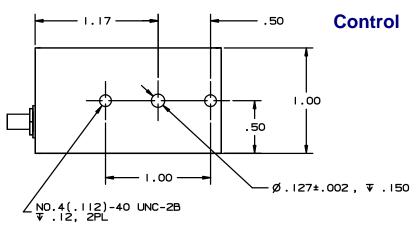
PERFORMANCE VS BEAM DIAMETER

Beam Diameter (µm)		50	65
at Wavelength (nm)		1060	1060
Diffraction Efficiency (%)		75	80
Rise Time (nsec)		10	12
Modulation Bandwidth		NA	NA
Beam Ellipticity		NA	NA
Special Testing	Min	Units	Max
Loss Modulation	80	%	

Outline Drawing:



11/29/07



Notes

Loss Modulation 85% Min. at 50 µm beam diameter.

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TOLERANCES: .XX ± .01 .XXX ± .005	DR	Geri Scholz 11/29/2007	Crystal Technology, Inc.		
MATERIAL:	СНК		DESCRIPTION: AOMO	3200-11	13
FINISH:	APP		TEO2; 1.06 μm; 200 MHz		
Compliant	APP		PART NUMBER: 97-02029-55	REV:	SHEET 1 OF 1

^{*}Active Aperture: Aperture over which performance specifications apply.